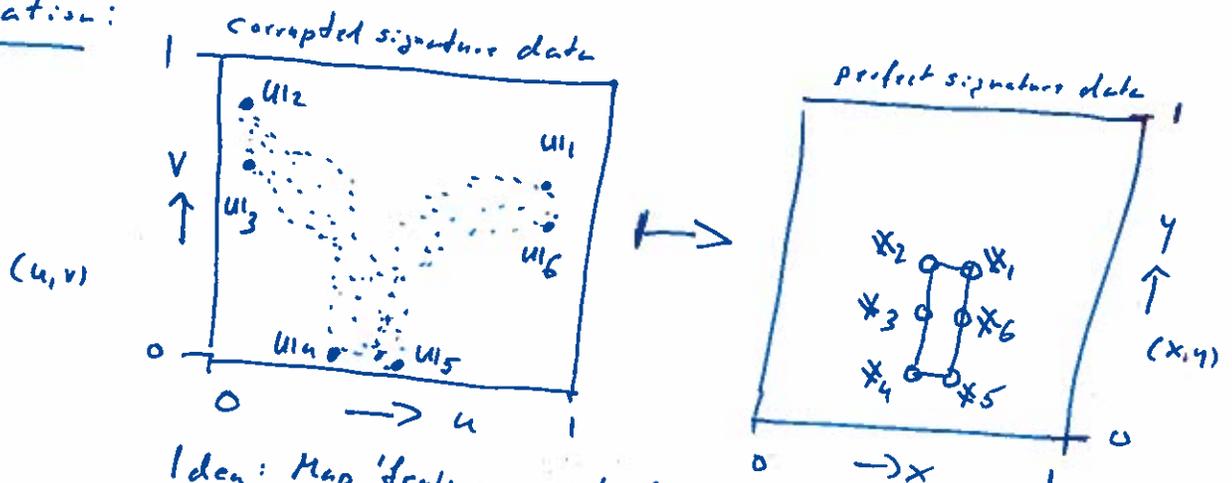


• Possibilities to Map Distributions (of Signature Data)

→ "Goal": Define a mapping that 'maps back'
a recorded distribution of k -dimensional
signature data to its 'perfect location'.
ALSO: Want to define such a mapping
for just a small no. of signature
dimensions - e.g., 2 □

• Ex: Select 2 dimensions of recorded/imaged
signature data of the same material
imaged under different conditions, - and
map that 2-d distribution to the 'ideal'
'perfect' distribution/location in 2-d space...

• Illustration:



Idea: Map 'feature points' from (u,v) -space to
corresponding points in (x,y) -space

⇒ Use a 'relatively low-degree'
polynomial for the mapping:

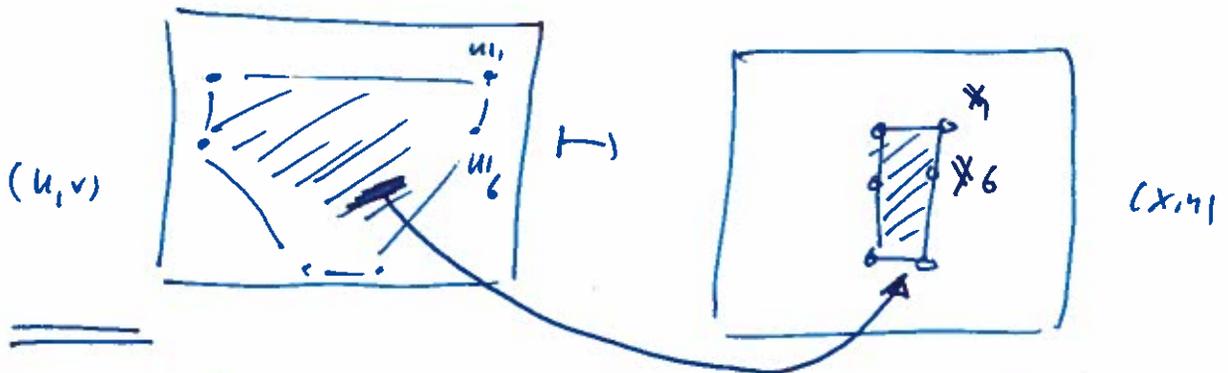
L I N E A R
S Y S T E M

$$\begin{cases} X_1 = \begin{pmatrix} x_1 \\ y_1 \end{pmatrix} = c_{00} + c_{10}u_1 + c_{01}v_1 + c_{20}u_1^2 + c_{11}u_1v_1 + c_{02}v_1^2 \\ \quad \quad \quad = \sum_{\substack{i+j \leq 2 \\ i,j \geq 0}} c_{i,j} u_1^i v_1^j \\ \vdots \\ X_6 = \begin{pmatrix} x_6 \\ y_6 \end{pmatrix} = \sum c_{i,j} u_6^i v_6^j \end{cases}$$

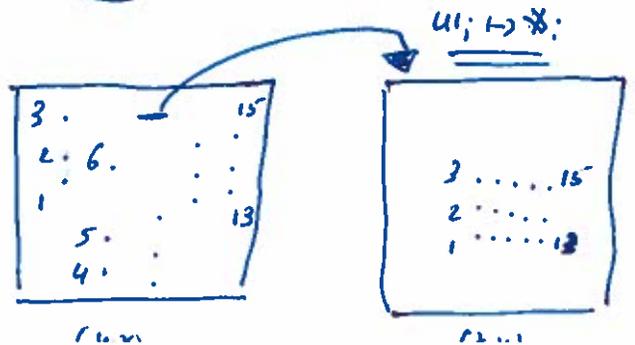
⇒ $X_k = \sum c_{i,j} u_k^i v_k^j$, $k=1 \dots 6$

⇒ determine the unknown
coefficients $c_{i,j} = \begin{pmatrix} c_{i,j}^u \\ c_{i,j}^v \end{pmatrix}$.

⇒ The mapping $(u,v) \mapsto (x,y)$ actually
defines a 'continuous' mapping for the
 (u,v) -plane to the (x,y) -plane:

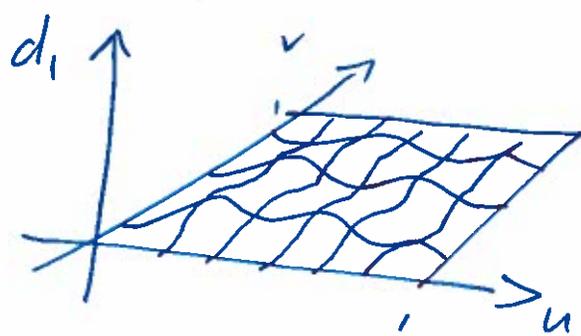


• OR: Could AUTOMATICALLY (!)
Generate MANY corresponding
point pairs $(u,v)_i, (x,y)_i$
and determine a LEAST-SQUARES
low-degree polynomial for
a mapping:

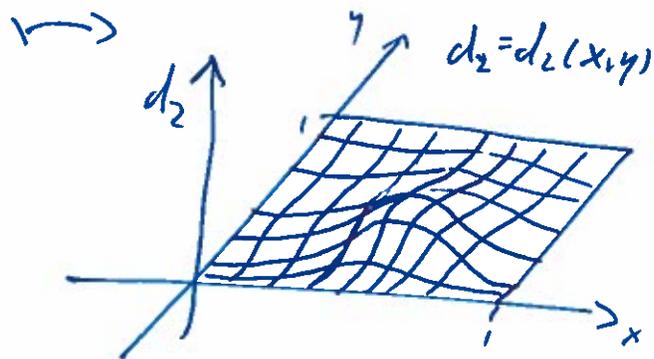


Different View point

→ View the problem as a CONTINUOUS problem where one continuous distribution/density must be mapped to another

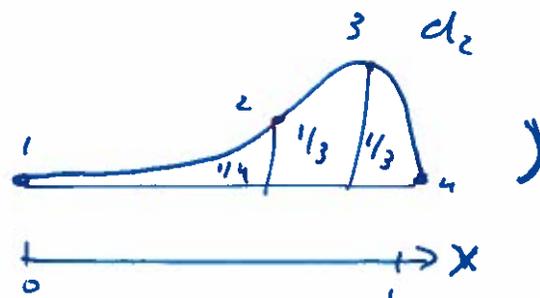
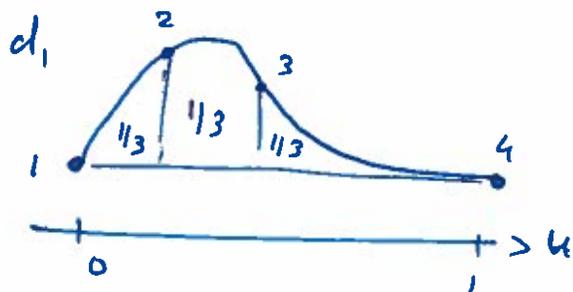


Corrupted/Imaged

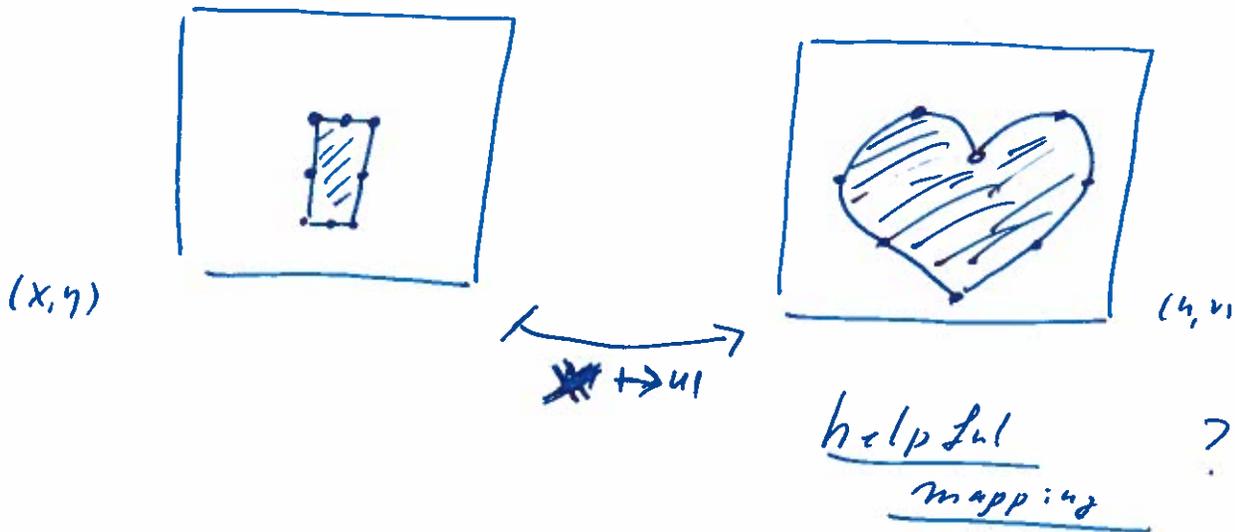


Perfect/Ideal

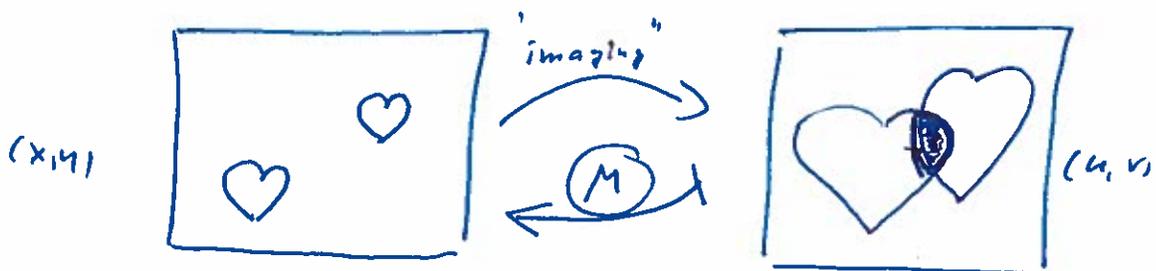
⇒ Use an INTEGRAL-based method to map d_1 to d_2 (similarly to mapping 2 1-d histograms to each other via integral-based correspondences :



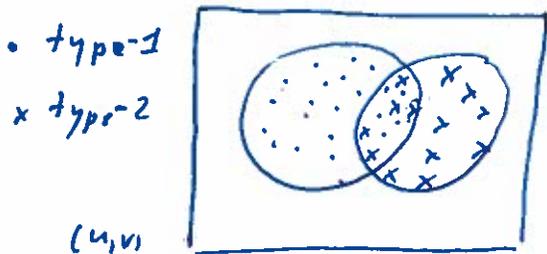
- Can "insight" be gained by defining / understanding the mapping from X (product) to U (image)?



- CONTEXT: The ideal/correct signature date of 2 materials "do not overlap" in (x,y) -space - but they "do overlap" in (u,v) -space?

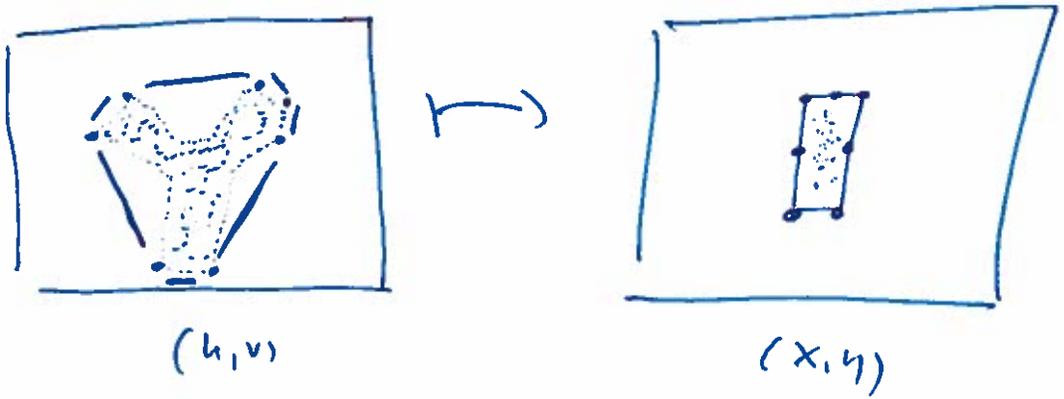


QUESTION: Can a mapping from (u,v) - to (x,y) -space be used to RESOLVE THE AMBIGUITY in (u,v) -space ??? WHEN A (u,v) -tuple lies in overlap region, is it type-1 or type-2 ???



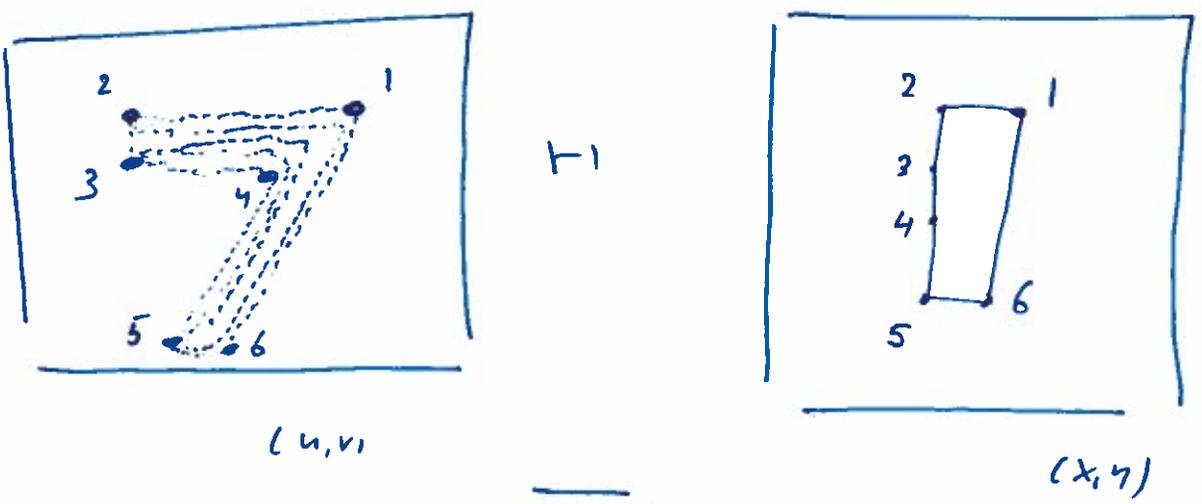
"Map (u,v) -tuple to (x,y) -space using ALL mappings for all material types; minimal-energy-mapping"

• CONVEX HULLS HELPFUL?

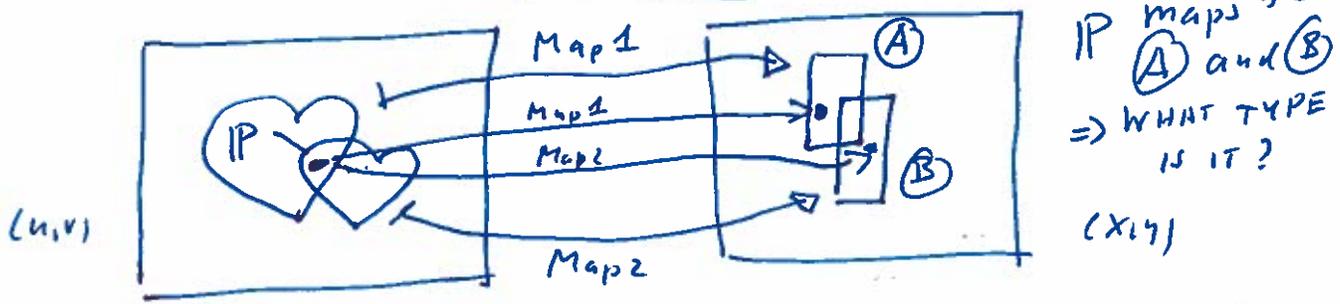


• CONFORMAL MAP?

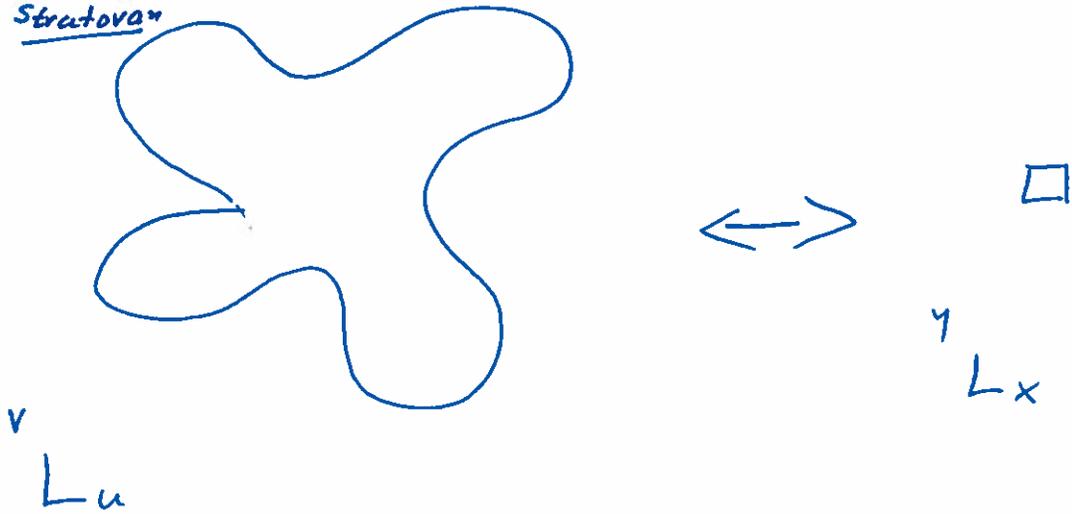
"Map points on non-convex outlines at boundaries to each other"



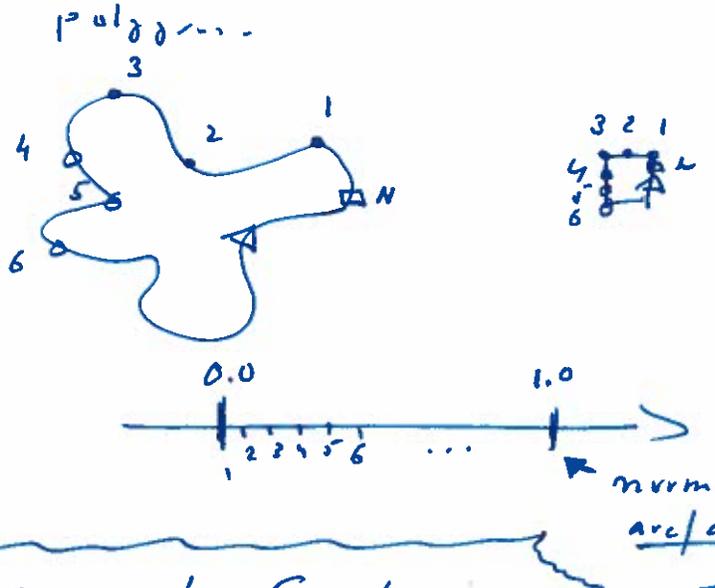
• Must resolve the AMBIGUITY:



Stratovan

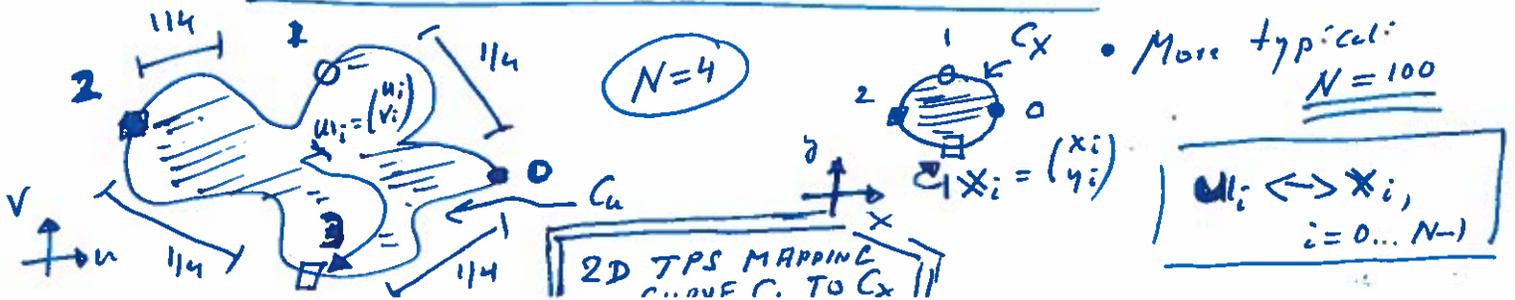


- chord-length parameterize the boundary polygons
- establish AUTOMATIC correspondence between points on outlines



Map Closed Curve to Circle

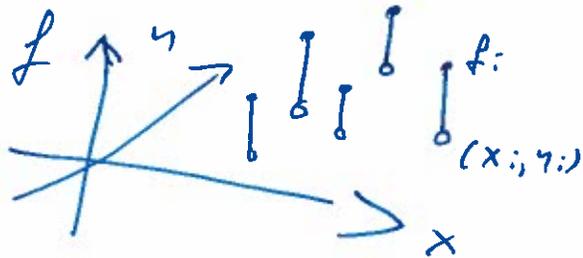
→ Correspondence via arc length.



Stratovon

■ Using Standard TPS for Mapping

• Review: TPS (Scattered Data Setting)



$$\left\{ \begin{aligned} \sum w_i &= 0, \\ \sum w_i x_i &= 0, \\ \sum w_i y_i &= 0 \end{aligned} \right\}$$

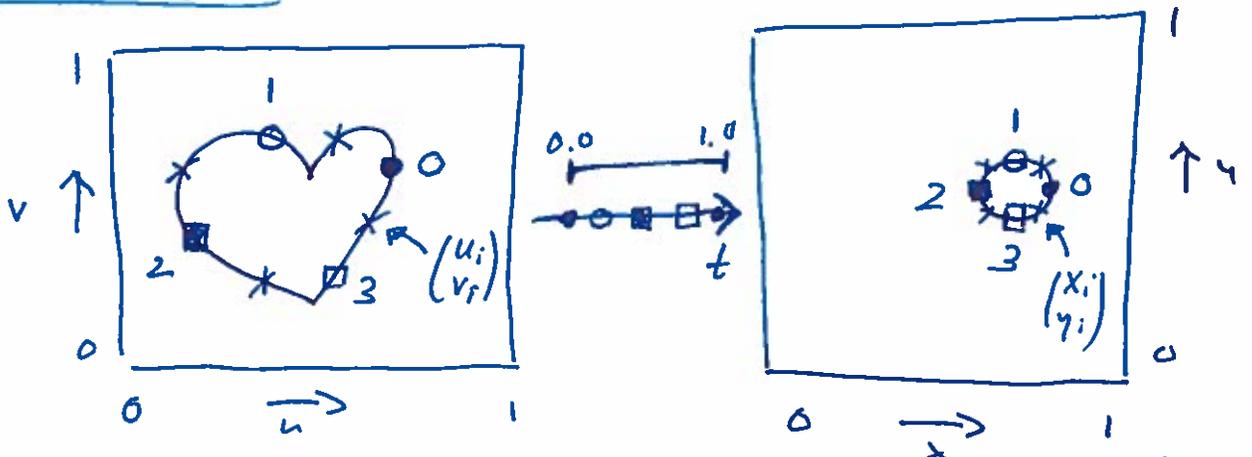
• $TPS = f(x,y) = a + bx + cy + \sum_{i=1}^N w_i \cdot f_i(x,y)$

$$f_i(x,y) = d_i^2 \cdot \log(d_i)$$

$$d_i^2 = d_i^2(x,y) = (x - x_i)^2 + (y - y_i)^2$$

- Compute coefficients a, b, c, w_i s.t. function $f(x,y)$ interpolates the given function values.

• Our Setting:



- Points are UNIFORMLY distributed on the 2 curves.
- 2 points 'correspond' when they have the same t -value
- Compute the 2 TPS FUNCTIONS:

$$x = x(u,v), \quad y = y(u,v)$$